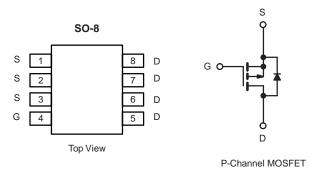


HAT1129R-VB Datasheet P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)			
- 30	0.011 at V _{GS} = - 10 V	- 11.6	22 nC			
- 30	0.012 at V _{GS} = - 4.5 V	- 10	22110			



FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Load Switches
- Notebook PCs
 - Desktop PCs



COMPLIANT HALOGEN

FREE Available

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 30	V		
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		- 11.6		
Continuous Drain Current (T $= 150$ °C)	T _C = 70 °C		- 10.5		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 8.7 ^{a, b}		
	T _A = 70 °C		- 7.7 ^{a, b}		
Pulsed Drain Current	I _{DM}	- 40	— A		
	T _C = 25 °C		- 4.6		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.0 ^{a, b}		
Avalanche Current	. 0.4 mll	I _{AS}	- 20		
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	20	mJ	
	T _C = 25 °C		5.6		
Mauianum Daura Diasia stian	T _C = 70 °C	р	3.6	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{a, b}		
	T _A = 70 °C	1	1.6 ^{a, b}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	39	50	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	18	22	C/W	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

c. Maximum under Steady State conditions is 85 °C/W. d. Based on $T_C = 25$ °C.

b. t = 10 s.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					•	1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 31		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 230 μA		5.5		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1.0		- 3.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ °C}$			- 1 - 5	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, \text{ V}_{GS} = -10 \text{ V}$	- 30			А
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -10 \text{ A}$ $V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -7 \text{ A}$		0.011 0.012		Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 10 A		23		S
Dynamic ^b	0.0	50 5		I		I
Input Capacitance	C _{iss}			1960		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		380		pF
Reverse Transfer Capacitance	C _{rss}			325		
Total Gate Charge	Q _g	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 10 A		43 22	65 33	
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 10 A		6		nC
Gate-Drain Charge	Q _{gd}			11		
Gate Resistance	R _g	f = 1 MHz	0.3	1.3	2.5	Ω
Turn-On Delay Time	t _{d(on)}			11	22	
Rise Time	t _r	$V_{DD} = -15 V, R_1 = 3 \Omega$		13	25	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -5 \text{ A}, V_{GEN} = -10 \text{ V}, \text{ R}_{g} = 1 \Omega$		32	50	
Fall Time	t _f			9	18	
Turn-On Delay Time	t _{d(on)}			44	70	ns
Rise Time	t _r	V_{DD} = - 15 V, R _L = 3 Ω		100	160	
Turn-Off DelayTime	t _{d(off)}	${\sf I}_{\sf D}\cong$ - 5 A, ${\sf V}_{\sf GEN}$ = - 4.5 V, ${\sf R}_{\sf g}$ = 1 Ω		28	50	
Fall Time	t _f			15	30	
Drain-Source Body Diode Characterist	ics					
Continuous Source-Drain Diode Current	۱ _s	T _C = 25 °C			- 4.6	٨
Pulse Diode Forward Current	I _{SM}				- 50	A
Body Diode Voltage	V _{SD}	I _S = - 2 A, V _{GS} = 0 V		- 0.75	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			28	45	ns
Body Diode Reverse Recovery Charge	Q _{rr}	L = 2 A dl/dt = 100 A/up T = 25 °C		20	40	nC
Reverse Recovery Fall Time	t _a	- I _F = - 2 A, dl/dt = 100 A/μs, T _J = 25 °C		13		-
Reverse Recovery Rise Time	t _b			15		ns

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



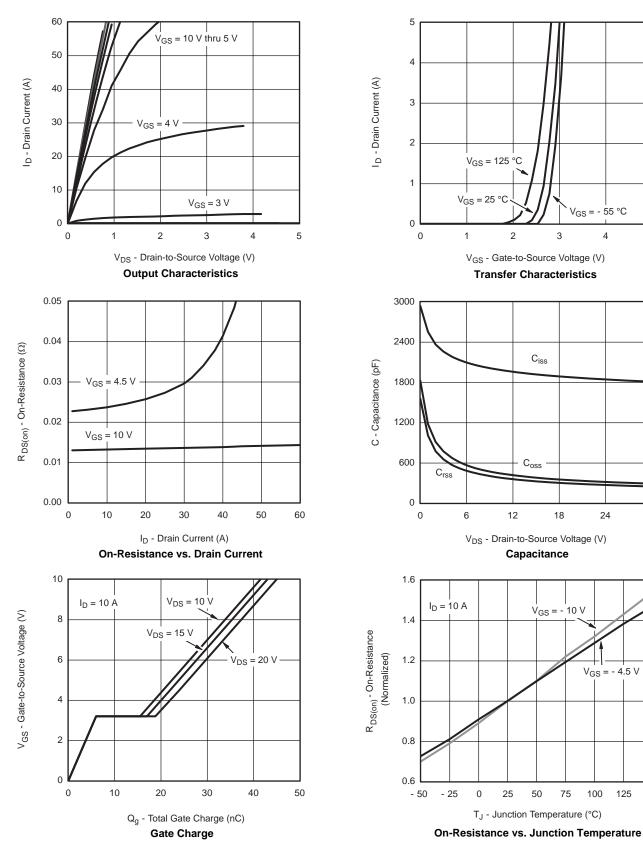
V_{GS} = - 55 °C

 C_{iss}

 $V_{GS} = -10 V$

 $V_{GS} = -4.5 V$

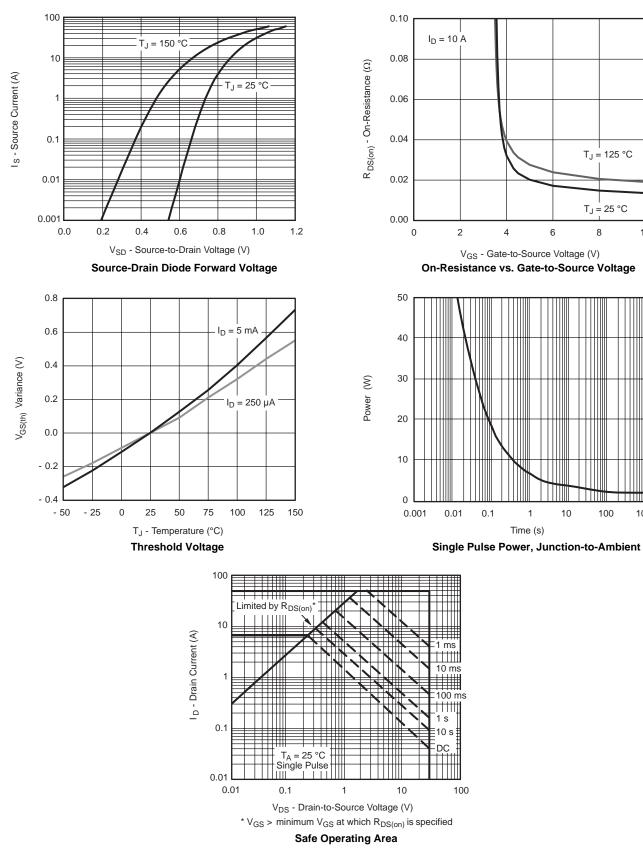
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





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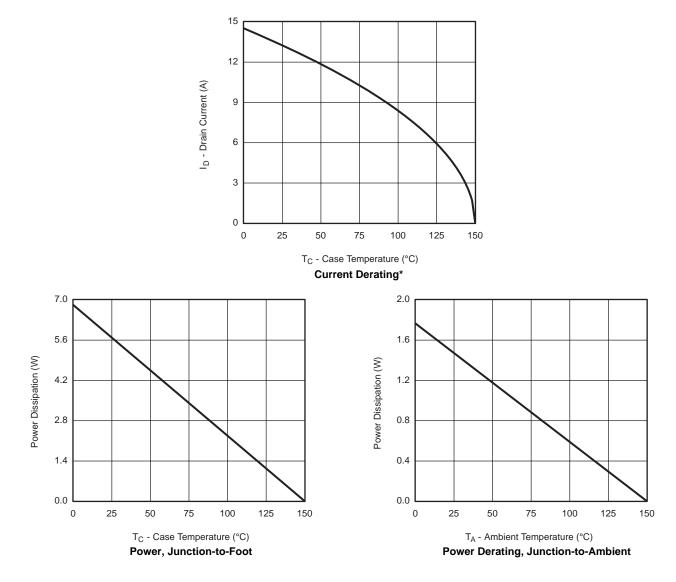
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



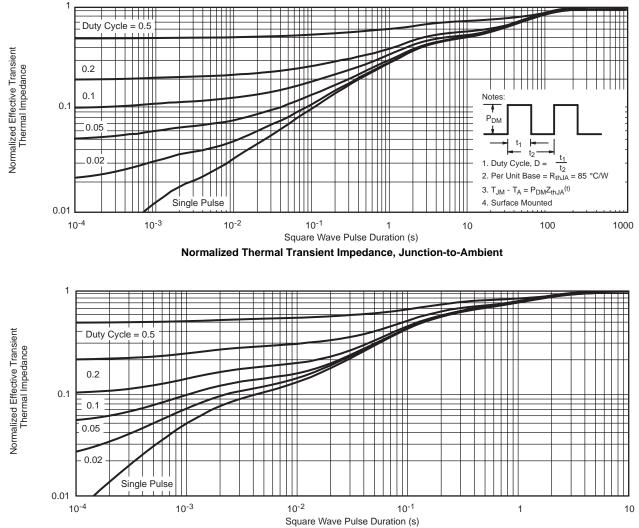
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



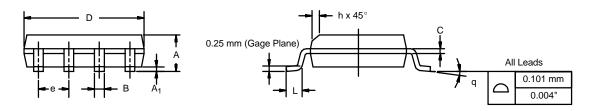
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012





	MILLIMETERS		INC	HES	
DIM	Min	Max	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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